## Notice of References Cited Reexamination PRABHU ET AL. Examiner Jacob K. Ackun Jr. Reexamination PRABHU ET AL. Page 1 of 1

Application/Control No.

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,261,157	07-2001	Bajaj et al.	451/57
	В	US-6,595,831	07-2003	Hirokawa et al.	451/36
	С	US-6,783,432	08-2004	Li et al.	451/36
	D	US-6,709,316	03-2004	Sun et al.	451/41
	Ε	US-6,676,484	01-2004	Chopra, Dinesh	451/7
	F	US-6,443,807	09-2002	Sakai et al.	451/5
	G	US-5,676,587	10-1997	Landers et al.	451/57
	Н	US-2002/0173221	11-2002	Li et al.	451/5
	ı	US-2002/0146965	10-2002	Thomas et al.	451/41
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	. Name	Classification
	N					
	0				·	
	Р					*
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under